Please amend the subject application as follows:

IN THE CLAIMS:

Please cancel claim 3 and accept amended claims 1, 4, 23, 25 and 26 as follows:

- 1. (currently amended) A capacitor comprising:
- a lower electrode formed on a semiconductor substrate;
- a dielectric film stacked on the lower electrode; and
- an upper electrode, comprising a first upper electrode and a second upper electrode, formed on the dielectric film, wherein:

the <u>second</u> upper electrode is formed by chemical vapor deposition and <u>the first upper electrode is formed by physical vapor deposition,</u>

a bias power is applied only to a target when the first upper electrode is formed by the physical vapor deposition, and

the capacitor is a concave-type capacitor.

- 2. (original) The capacitor of claim 1, wherein the upper electrode is made of one selected from the group consisting of titanium nitride, tantalum nitride, tungsten nitride, ruthenium, platinum, iridium, and a combination thereof.
 - 3. (canceled)
- 4. (currently amended) The capacitor of claim 1, wherein the upper electrode includes a first upper electrode formed by the physical vapor deposition and a second

upper electrode formed by the chemical vapor deposition and the first upper electrode and the second upper electrode are sequentially stacked.

- 5. 22. (canceled)
- 23. (currently amended) A capacitor comprising:
 a lower electrode formed on a semiconductor substrate;
 a dielectric film stacked on the lower electrode; and
 an upper electrode formed on the dielectric film, wherein:

the upper electrode is formed by physical vapor deposition and one of chemical vapor deposition and atomic layer deposition,

the upper electrode includes a first upper electrode <u>formed by physical</u>

<u>vapor deposition</u> and a second upper electrode <u>formed by one of chemical vapor</u>

deposition and atomic layer deposition,

a bias power is applied only to a target when the first upper electrode is formed by the physical vapor deposition, and

the capacitor is a concave-type capacitor.

- 24. (canceled)
- 25. (currently amended) A capacitor comprising:a lower electrode formed on a semiconductor substrate;a dielectric film stacked on the lower electrode; and

an upper electrode formed on the dielectric film, wherein:

the upper electrode is formed by chemical vapor deposition and physical vapor deposition, and

the upper electrode includes a first upper electrode formed by physical vapor deposition and a second upper electrode formed by chemical vapor deposition, and

a bias power is applied only to a target when the first upper electrode is

formed by the physical vapor deposition; and

an anti-reflective layer formed on the second upper electrode.

26. (currently amended) The capacitor of claim 25, wherein the capacitor is a concave type capacitor further comprising an anti-reflective layer formed on the second upper electrode.